

<b>Notice of References Cited</b>	Application/Control No. 10/749,596	Applicant(s)/Patent Under Reexamination KIM ET AL.	
	Examiner Donghee Kang	Art Unit 2811	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,624,463	09-2003	Kim et al.	257/310
	C	US-			
	D	US-			
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	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	D.M.Newns et al., "Mott transition field effect transistor", Applied Physc. Lett., (73) 1998, pp 780.
	V	C.Zhou et al., "A field effect transistor based on the MOtt transition in a molecular layer", Appl. Phys.Lett., (70), 1997, pp 598.
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.